

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10538750	TAN ET AL.
	Examiner	Art Unit
	MICHAEL DOLLINGER	1796

SEARCHED

Class	Subclass	Date	Examiner
525	460, 450	12/4/2008	/mmd/

SEARCH NOTES

Search Notes	Date	Examiner
Inventors' name search in eDAN and EAST in USPAT and USPGPUB		
EAST search in USPAT USOCR USPGPUB	12/4/2008	/MMD/
EAST search in USPAT USPGPUB USOCR DERWENT EPO JPO	07/14/2009	/mmd/
EAST search in USPAT USPGPUB USOCR DERWENT EPO JPO	12/02/2009	/mmd/
EAST search in USPAT USPGPUB USOCR DERWENT EPO JPO	06/10/2010	/mmd/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/M. D./
Examiner.Art Unit 1796